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Filing Date	01/28/02		
First Named Inventor	Chen et al.		
Group Art Unit	2812		100
Examiner Name	Unknown		10 mg/ PM
Attorney Docket Number	AP01983	- North British Control	W # 15.

Examiner	Cite	U.S. Patent Document	Name of Patentee or Applicant	Date of Publication	Pages, Columns, Lines, Where
Initials*	No. 1	Number Kind Code ² (if known)	of Cited Document	of Cited Document MM-DD-YYYY	Relevant Passages or Relevant Figures Appear
1441		3,761,784	Jund	07/04/1989	
	-1- ** · 0:\$	4,191,057	Busta	05/27/1997	
Tarib	1,	4,275,406	Muller et al.	06/23/81	
		4,317,126	Gragg, Jr.	02/23/82	
		4,395,451	Althouse	07/26/83	
		4,444,054	Schaff, Jr	04/24/84	
2	-	4,667,944	Althouse	05/26/87	
		4,683,755	Samek	08/04/87	
		4,711,014	Althouse	12/08/87	
- 1		4,986,861	Nishida et al.	01/22/91	
and the second	- '- '	4,996,627	Zias et al.	02/26/91	
		5,356,176	Wells	10/18/94	
		5,629,486	Viduya et al.	05/13/97	
I	1	5,644,102	Rostoker	07/01/97	
AUI		5,917,264	Maruno et al.	06/29/99	
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	8,7				
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	- 2			FOR	EIGN	PATENT DOCUME	NTS		1
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Application Number	10/058,557	£;	m	13.1	
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Group Art Unit	2812			70	
Examiner Name	Unknown	108 1	G	s islands.	111
Attorney Docket Number	AP01983	. x			

100	I	OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	72
Examiner Initials*	Cite No. 1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or county where published.	T*
AUU		"Micromachines on the March" Janusz Bryzek, Kurt Petersen, and Wendell McCulley. IEEE Spectur, May 1994, pp 20-31.	
		"Ultra Thin ICs Open New Dimensions for Microelectric Systems" G. Klink, C. Landesberger, M. Feil, F. Ansorge, R. Aschenbrenner. Advancing Microelectronics, July/August 2000; pp.23-25.	•
		"New Process Scheme for Wafer Thinning and Stress-free Seperation of Ultra Thin ICs" C. Landesberger, S. Scherbaum, G. Schwinn, H. Spohrle. Proceedings of Microsystems Technologies 2001; pp 1-7.	
		"Innovative Packaging Concepts for Ultra Thin Integrated Circuits" G. Klink, M. Feil, F. Ansorge, R. Aschenbrenner, H. Reichl. Electonic Components and Technology Conference, 2001; pp. 1034-1039.	
		"Thin Silicon Chips and ACF Connection Technology for Contactless IC Cards" Mitsuo Usami. 1999 International Symposium on Microelectronics; pp. 309-312.	.,
		"Mechanical Lapping, Handling and Transfer of Ultra-Thin Wafers" S. Pinel, J. Tasselli, J.P. Bailbe, A. Marty, P. Puech and D. Esteve. Microengineering Vol. 8, 1998; pp 338-342.	5
	1	"SmartCard Assembly Requires Advanced pre-Assembly Methods" Dr. J. Muller, P. Stampka, W. Kruninger, E. Gaulhofer, H. Oyrer. Semiconductor Internationall, July 2000; pp. 191-200.	
		"Thin Monocrystalline Silicon Films on Flexible Substrates Enable Multiple Transfer Processes" C. berge, Dr. R. Bergmann, D. J. Werner. MRS Bulletin, August 2001; pp. 603.	
		Khazan, A.D., "Transductors and Their Elements: Design and Application." Prentice-Hall, Inc. 1994, ISBN 03-13-929480-5. pp 393-395.	
THE	,	"Packaging Very High Pressure Transducers for Common Rail Diesel Injection Systems" K. Sidhu, Measurement Specialties, Inc. October 1987, pp. 1-4	

Examiner		11/	1//	Date		/ /		
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